



**Alfa-MOS
Technology**

**AFN2444WS
30V N-Channel
Enhancement Mode MOSFET**

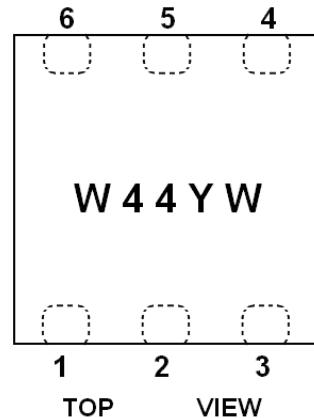
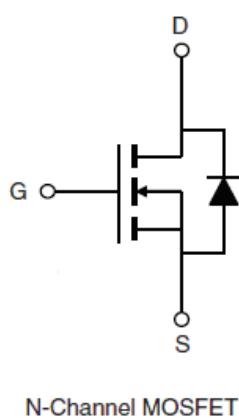
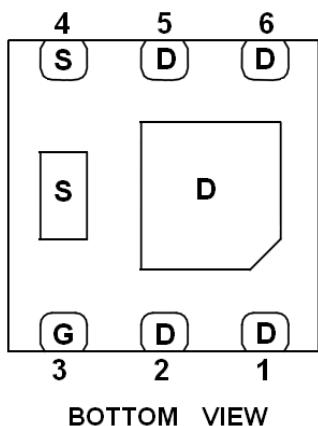
General Description

AFN2444WS, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent $R_{DS(ON)}$, low gate charge. These devices are particularly suited for low voltage power management, and low in-line power loss are needed in commercial industrial surface mount applications.

Features

- $I_D=3.0A, R_{DS(ON)}=15m\Omega @ V_{GS}=10V$
- $I_D=3.0A, R_{DS(ON)}=20m\Omega @ V_{GS}=4.5V$
- Super high density cell design for extremely low $R_{DS(ON)}$
- DFN2X2-6L package design

Pin Description (DFN2X2-6L)



Application

- DC/DC Converter
- High Frequency Switching

Pin Define

Pin	Symbol	Description
1,2,5,6	D	Drain
4	S	Source
3	G	Gate

Ordering Information

Part Ordering No.	Part Marking	Package	Unit	Quantity
AFN2444WSFN226RG	W44YW	DFN2X2-6L	Tape & Reel	4000 EA

* W44 part code

* Y year code

* W week code

* AFN2444WSFN226RG : 7" Tape & Reel ; Pb- Free ; Halogen- Free



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Absolute Maximum Ratings

($T_A=25^\circ\text{C}$ Unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	30	V
Gate –Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current($T_J=150^\circ\text{C}$)	I_D	11	A
		8.8	
Pulsed Drain Current	I_{DM}	40	A
Continuous Source Current(Diode Conduction)	I_S	2.9	A
Power Dissipation	P_D	3.5	W
		2.2	
Operating Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55/150	$^\circ\text{C}$
Thermal Resistance-Junction to Ambient	$R_{\theta JA}$	36	$^\circ\text{C}/\text{W}$

Electrical Characteristics

($T_A=25^\circ\text{C}$ Unless otherwise noted)

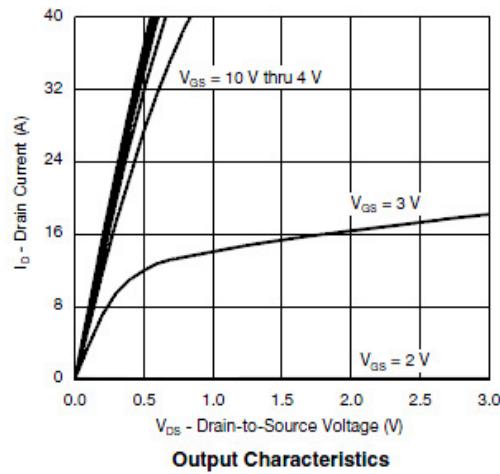
Parameter	Symbol	Conditions	Min.	Typ	Max.	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	30			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0		2.5	
Gate Leakage Current	I_{GSS}	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=24\text{V}, V_{GS}=0\text{V}$			1	uA
		$V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$			10	
On-State Drain Current	$I_{D(\text{on})}$	$V_{DS}\geq 5\text{V}, V_{GS}=10\text{V}$	20			A
Drain-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=3.0\text{A}$		11	15	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=3.0\text{A}$		14	20	
Forward Transconductance	g_{FS}	$V_{DS}=10\text{V}, I_D=7.4\text{A}$		24		S
Diode Forward Voltage	V_{SD}	$I_S=3.0\text{A}, V_{GS}=0\text{V}$		0.85	1.3	V
Dynamic						
Total Gate Charge	Q_g	$V_{DS}=15\text{V}, V_{GS}=4.5\text{V}$ $I_D=11\text{A}$		5	10	nC
Gate-Source Charge	Q_{gs}			1.5		
Gate-Drain Charge	Q_{gd}			1.7		
Input Capacitance	C_{iss}	$V_{DS}=15\text{V}, V_{GS}=0\text{V}$ $f=1\text{MHz}$		560		pF
Output Capacitance	C_{oss}			125		
Reverse Transfer Capacitance	C_{rss}			55		
Turn-On Time	$t_{d(\text{on})}$	$V_{DD}=15\text{V}, R_L=1.7\Omega$ $I_D=8.8\text{A}, V_{GEN}=4.5\text{V}$		12	25	ns
	t_r			12	25	
Turn-Off Time	$t_{d(\text{off})}$			15	30	
	t_f			10	20	



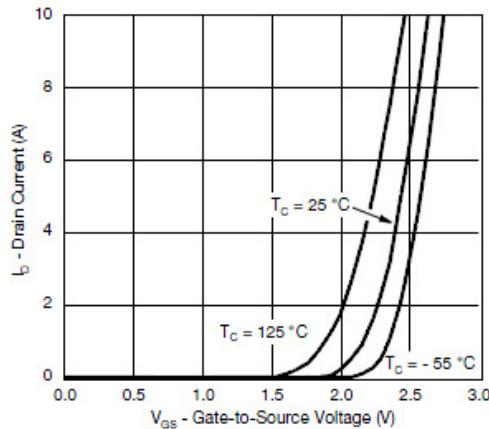
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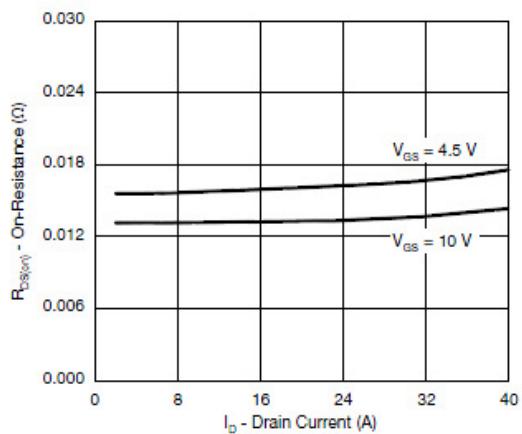
Typical Characteristics



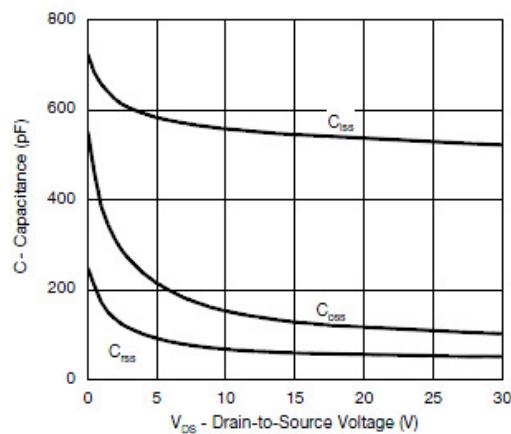
Output Characteristics



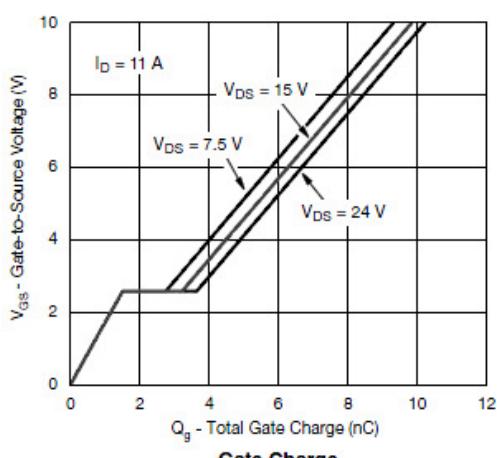
Transfer Characteristics



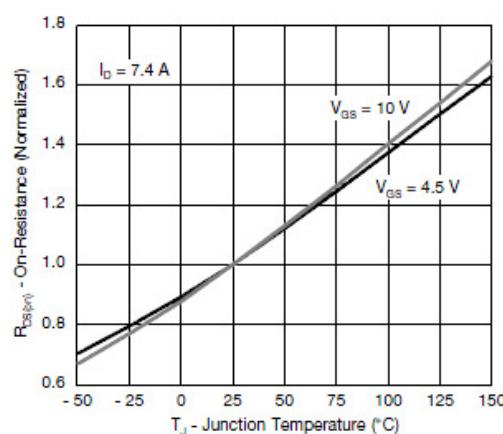
On-Resistance vs. Drain Current and Gate Voltage



Capacitance



Gate Charge



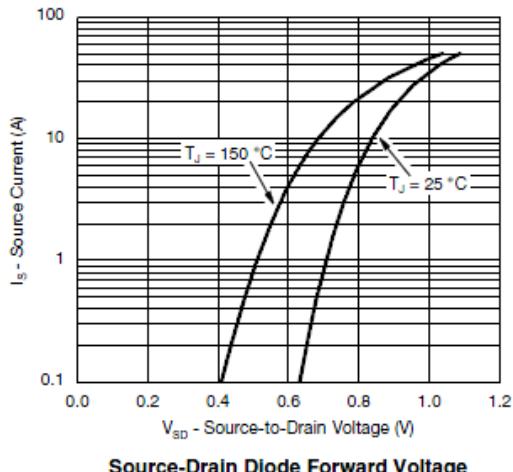
On-Resistance vs. Junction Temperature



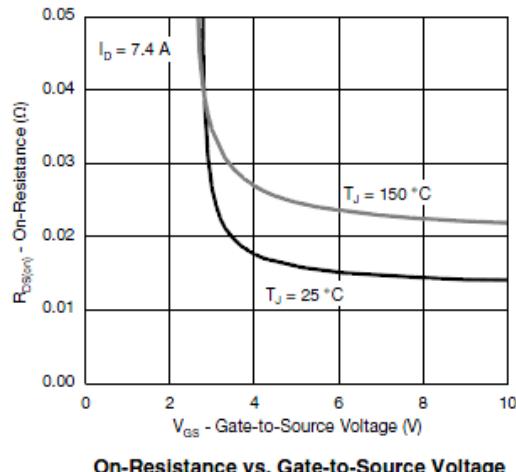
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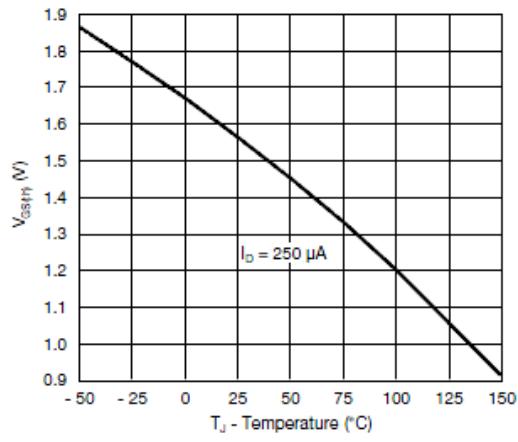
Typical Characteristics



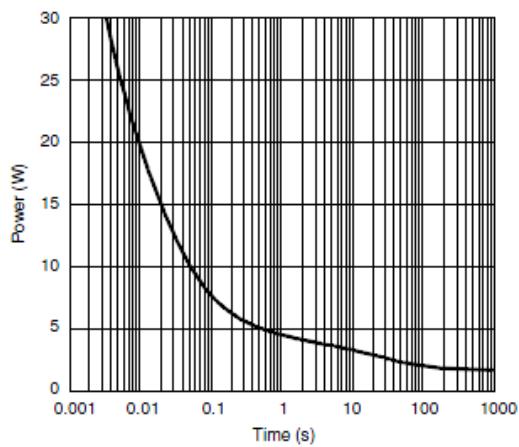
Source-Drain Diode Forward Voltage



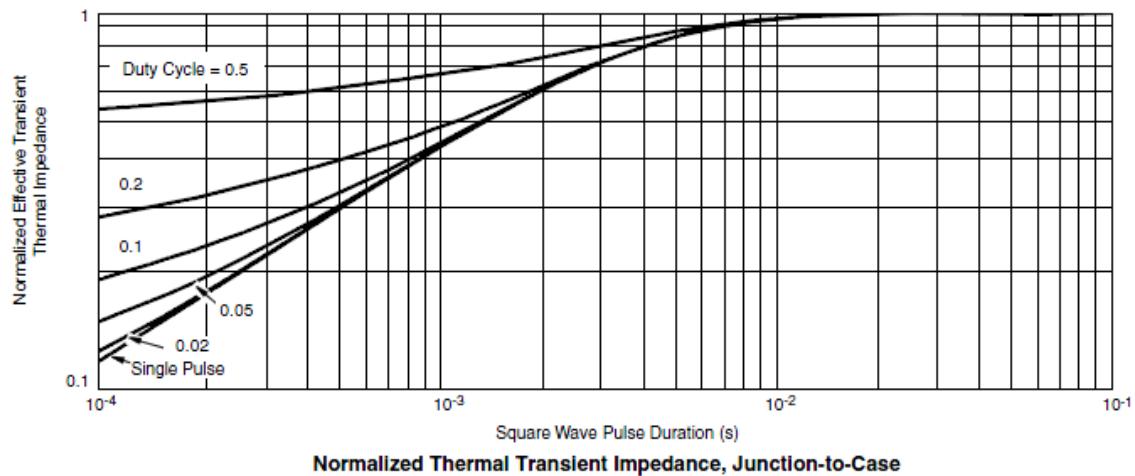
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power (Junction-to-Ambient)

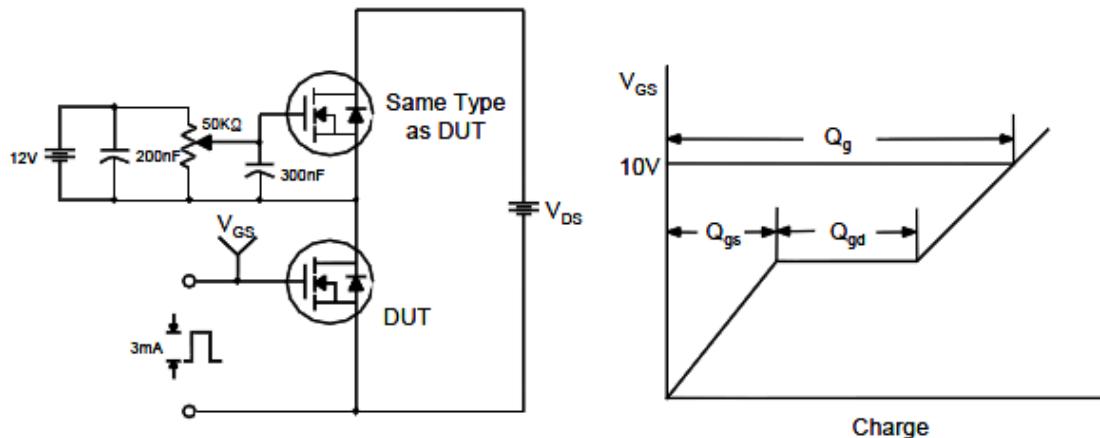


Normalized Thermal Transient Impedance, Junction-to-Case

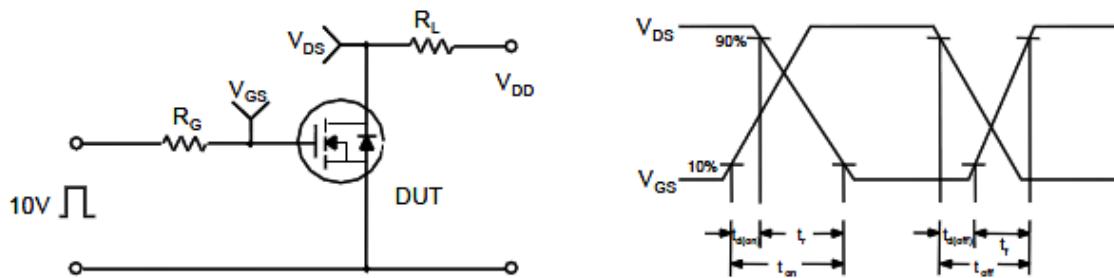


Typical Characteristics

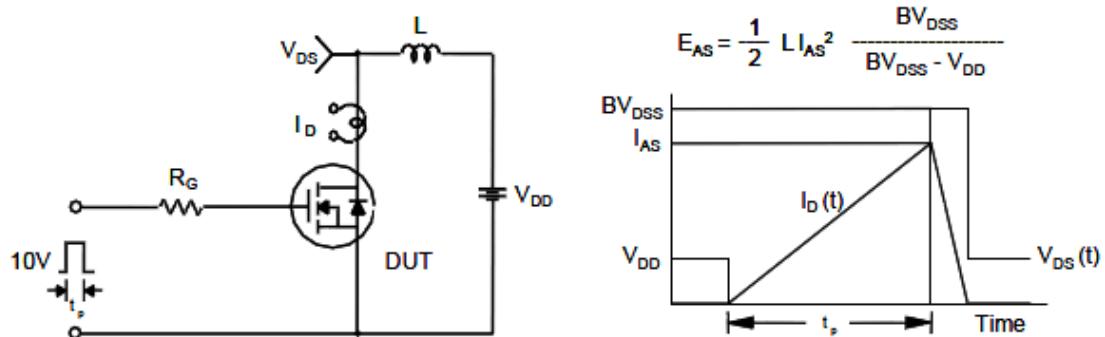
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

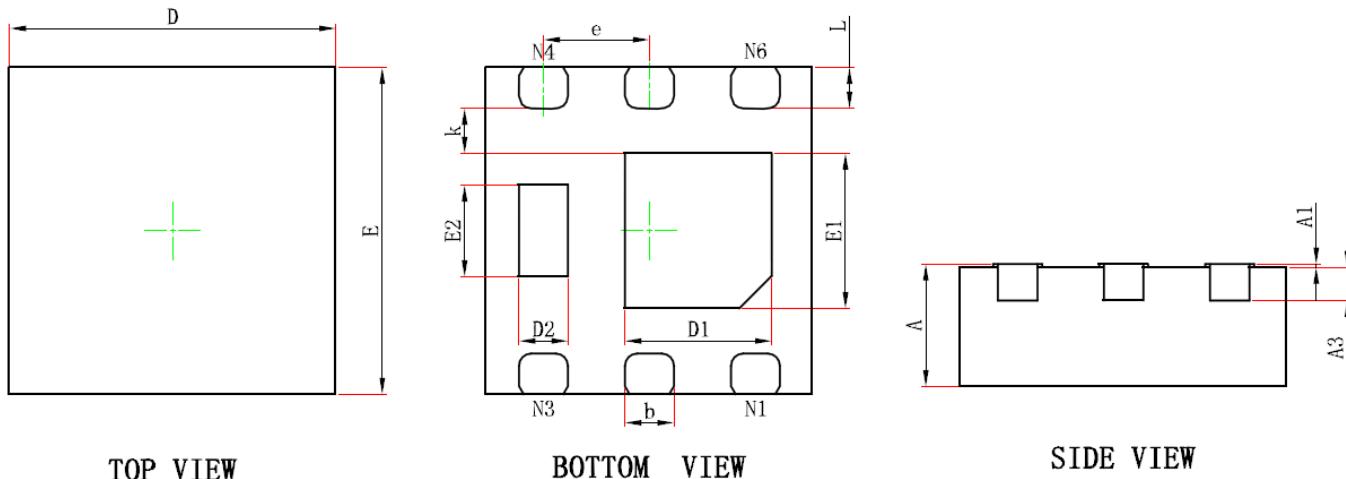




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Package Information (DFN2X2-6L)



TOP VIEW

BOTTOM VIEW

SIDE VIEW

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031
A1	0.000	0.050	0.000	0.002
A3	0.203REF.		0.008REF.	
D	1.924	2.076	0.076	0.082
E	1.924	2.076	0.076	0.082
D1	0.800	1.000	0.031	0.039
E1	0.850	1.050	0.033	0.041
D2	0.200	0.400	0.008	0.016
E2	0.460	0.660	0.018	0.026
k	0.200MIN.		0.008MIN.	
b	0.250	0.350	0.010	0.014
e	0.650TYP.		0.026TYP.	
L	0.174	0.326	0.007	0.013

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